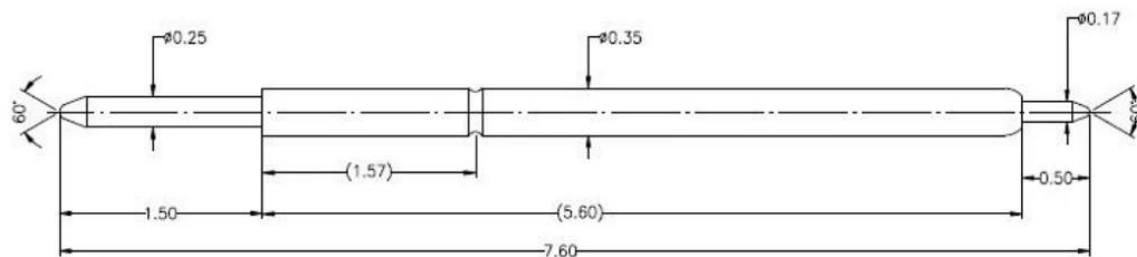


BGA

|  |                |
|--|----------------|
|  | ENG            |
|  | SF035B760B30   |
|  |                |
|  | B              |
|  | SWP            |
|  |                |
|  | 30 ±20 @0.65mm |
|  | 50m            |
|  | 1A             |
|  | 100            |
|  | 2-15           |





|                                  |                |                                |                      |                              |   |                                 |                   |
|----------------------------------|----------------|--------------------------------|----------------------|------------------------------|---|---------------------------------|-------------------|
| Probe Specifications<br>(探针各项参数) | Pitch<br>(中心距) | Pointing Accuracy<br>(直读度/偏角度) | Cycle Time<br>(循环寿命) | Contact Resistance<br>(接触电阻) | Current Rating-Continuous Time<br>(额定电流-持续时间) | Operating Temperature<br>(使用温度) | Bandwidth<br>(频宽) |
|                                  | /              | ±0.05mm                        | >80,000次             | 120mohm max                  | /   | -40~80℃                         | N/A               |

|                              |                    |                      |                    |                 |              |       |              |                  |       |         |  |  |
|------------------------------|--------------------|----------------------|--------------------|-----------------|--------------|-------|--------------|------------------|-------|---------|--|--|
| Name<br>(名称)                 | Travel(mm)<br>(行程) | Spring Force<br>(弹力) | Spring Probe       |                 |              |       | SF035B760B30 |                  |       |         |  |  |
| Initial Travel<br>(初始行程)     | /                  | /                    | Part(零件)           | Material(材质)    | Finish(表面处理) | Size  | A4           | Design           | Check | Approve |  |  |
| Recommended Travel<br>(推荐行程) | 0.65               | 30                   | Spring(弹簧)         | Music Wire      | Gold Plated  | Scale | 6:1          | 刘尚尚              |       |         |  |  |
| Full Travel<br>(全行程)         | 0.8                | /                    | Barrel(针管)         | Phosphor Copper | Gold Plated  | Unit  | mm           |                  |       |         |  |  |
|                              |                    |                      | Left Plunger(左针头)  | Becu            | Gold Plated  | Rev   | A0           | 胜峰科技 SFENG PROBE |       |         |  |  |
|                              |                    |                      | Right Plunger(右针头) | Becu            | Gold Plated  | Sheet | 1/1          |                  |       |         |  |  |

□□□□□□

- 1.we have 30 years experience in probe pin and have ourself factory.
- 2.we provide free sample and have a testing department.
- 3.we could manufacture products as your request.
- 4.we guarantee best price and good service.

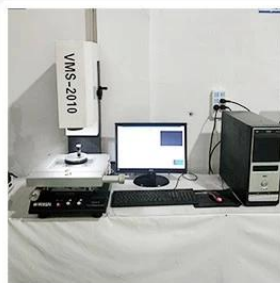
□□□□□□□□

Spring loaded pin (single) for PCB, ICT, FCT testing etc;  
Pogo pin (connector) to establish connection between two printed circuit boards for charging, locating, Battery, Semiconductor & Interconnect applications;  
Double ended probe for BGA and Semiconductor testing;  
Universal pin without spring, coating pin, LM pin with QZ and VZ series;  
High current probe, Switch probe, Capacitance needle;  
Terminal & receptacle /socket;  
Other related electronic components, 30# OK wire, Jig locks, POM, Iron hinge etc

□□□□□



1. Agilent current testing



2. Quadratic element



3. Load Curve Meter



4. Bond Test



5. Life Fatigue Test



6. Microscope

□□

Standard products will be delivered out within 3 days. Customized products will be sent out within 15 days.

